TECHSEM

Y65KKE
FAST TURN-OFF THYRISTOR

Features

- Interdigitated amplifying gates
- Fast turn-on and high di/dt
- Low switching losses

Typical Applications

- Inductive heating
- Electronic welders
- Self-commutated inverters

$I_{T(AV)}$	**2080A**
V_{DRM}/V_{RRM}	**800~1800V**
t_q	**18~50μs**
I_{TSM}	**21 kA**
I^2t	**2205 10^3A^2S**

SYMBOL	CHARACTERISTIC	TEST CONDITIONS		T_j(°C)	VALUE			UNIT
					Min	Type	Max	
$I_{T(AV)}$	Mean on-state current	180° half sine wave 50Hz Double side cooled,	T_C=55°C	125			2080	A
			T_C=85°C				1400	
V_{DRM} V_{RRM}	Repetitive peak off-state voltage Repetitive peak reverse voltage	V_{DRM}&V_{RRM} , tp=10ms V_{DSM}&V_{RSM}= V_{DRM}&V_{RRM}+100V		125	800		1800	V
I_{DRM} I_{RRM}	Repetitive peak current	V_D= V_{DRM} V_R= V_{RRM}		125			120	mA
I_{TSM}	Surge on-state current	10ms half sine wave		125			21	kA
I^2t	I^2T for fusing coordination						2205	A^2s*10^3
V_{TO}	Threshold voltage			125			1.41	V
r_T	On-state slop resistance						0.23	mΩ
V_{TM}	Peak on-state voltage	I_{TM}=4000A, F=32kN		125			2.33	V
dv/dt	Critical rate of rise of off-state voltage	V_{DM}=0.67V_{DRM}		125			500	V/μs
di/dt	Critical rate of rise of on-state current	V_{DM}= 67%V_{DRM} to3000A Gate pulse t_r ≤0.5μs I_{GM}=1.5A		125			1200	A/μs
Q_{rr}	Recovery charge	I_{TM}=2000A,tp=2000μs, di/dt=-60A/μs,V_R=50V		125		860		μC
tq	Circuit commutated turn-off time	I_{TM}=1700A,tp=1000μs, V_R =50V dv/dt=30V/μs ,di/dt=-20A/μs		125	18		50	μs
I_{GT}	Gate trigger current	V_A=12V, I_A=1A		25	40		400	mA
V_{GT}	Gate trigger voltage				0.9		4.0	V
I_H	Holding current				20		800	mA
V_{GD}	Non-trigger gate voltage	V_{DM}=67%V_{DRM}		125	0.3			V
$R_{th(j-c)}$	Thermal resistance Junction to case	At 180° sine double side cooled Clamping force 32kN					0.013	°C /W
$R_{th(c-h)}$	Thermal resistance case to heat sink						0.0035	
F_m	Mounting force				27		34	kN
T_{stg}	Stored temperature				-40		140	°C
W_t	Weight					820		g
Outline	KT60cT65							

Peak On-state Voltage Vs.Peak On-state Current

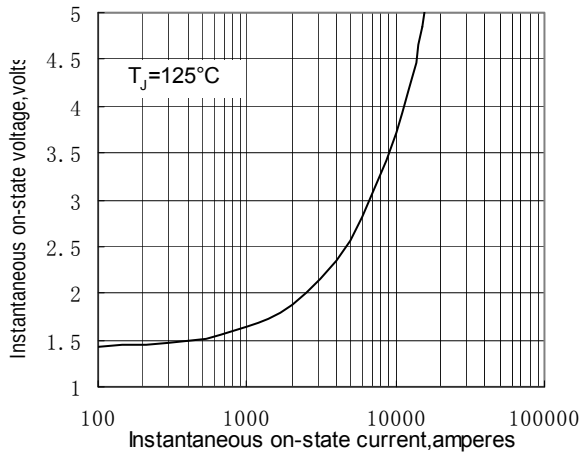

Fig.1

Max. junction To Case Thermai Impedance Vs.Time

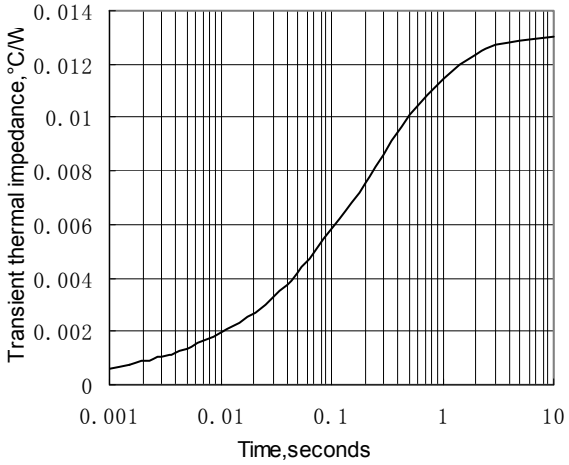

Fig.2

Surge Current Vs.Cycles

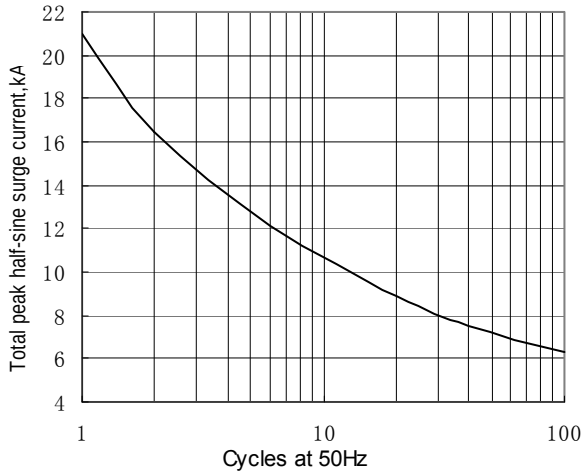

Fig.3

I²t Vs.Time

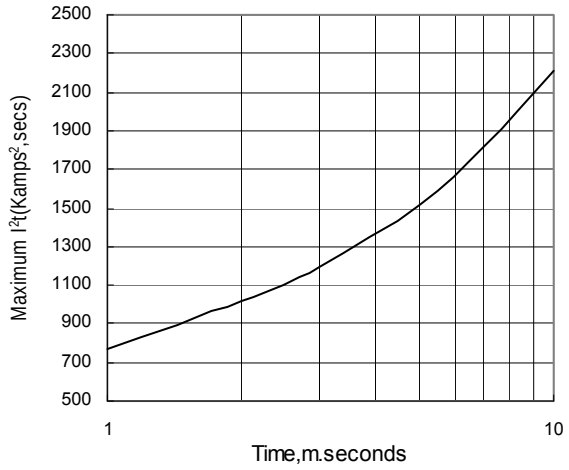

Fig.4

Gate characteristic at 25°C junction temperature

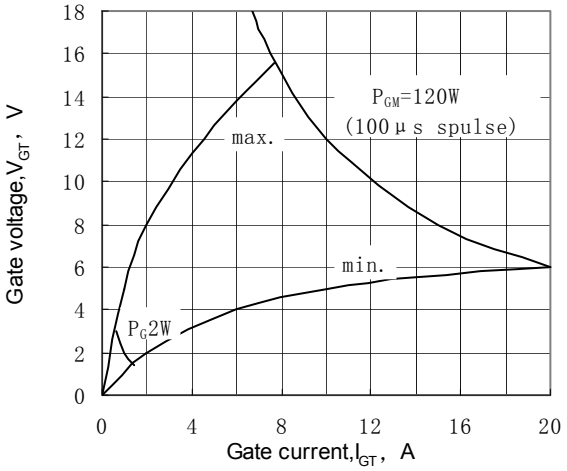

Fig.5

Gate Trigger Zone at varies temperature

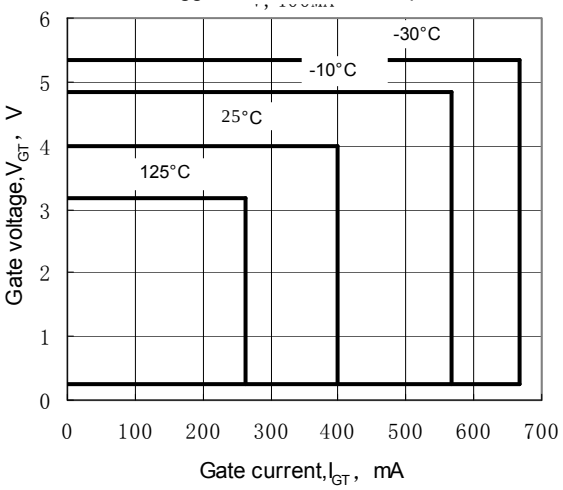

Fig.6

Outline: